## Notice of References Cited

Application/Control No.
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Examiner

Applicant(s)/Patent Under Reexamination AHN, SEUNG KUK

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,855,724	08-1989	Yang, Kei-Wean C.	345/88
	В	US-5,406,308	04-1995	Shiki, Tatsuya	345/99
	C	US-5,999,158	12-1999	Sekido et al.	345/98
	D	US-6,236,388 B	05-2001	lida et al.	345/698
	E	US-6,348,931_ <b>3</b>	02-2002	Suga et al.	345/699
	F	US-			
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-	·		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				**	
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	>	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.